Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | YOSHIDA ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,766,835 A	06-1998	Matsunaga, Naohiro	430/523
*	В	US-6,063,500 A	05-2000	Kurose et al.	428/425.9
*	С	US-2001/0016249 A1	08-2001	Kitamura et al.	428/195
*	D	US-6,689,432 B2	02-2004	Kitamura et al.	428/32.37
*	Ε	US-6,786,588 B2	09-2004	Koyano et al.	347/100
	F	US-			
	G	US-			
	Ι	US-			
	Ė	US-			
	7	US-			
	К	US-			
	L	US-	(*).		
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-2000-211248-A	08-2000	Japan	. Kunio et al.	
	0	JP-2002-011936-A	01-2002	Japan	Hiromine	
	Р	JP-H05-307734-A	11-1993	Japan	Toshinobu et al.	
	Q					
	R		•	* *		
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	υ							
	v							
	w							
	x							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.